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Application/Control No.	Applicant(s)/Patent under Reexamination
10/617,763	BUM, JAE-RYONG
Examiner	Art Unit

2181

Christopher B. Shin

SEARCHED					
Class	Subclass	Date ·	Examiner		
710	13,2,62- 65,72- 74,300- 306	6/11/2007	cs		
711	103,115	6/11/2007	cs		
		-			
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS	6/11/2007	cs		
EAST (US- PGPUB,USPAT,USOCR,FPRS,EPO,J PO,DERWENT,IBMTDB)	6/11/2007	cs		
PALM for double patenting	6/11/2007	cs		
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